



EMC TEST REPORT

Report No.: SET2016-18332

Product Name: LTE Ufi

FCC ID: SRQ-R218

Model No. : R218

Applicant: ZTE CORPORATION

Address: ZTE Plaza, Keji Road South, Shenzhen, China

Received Date: 2016-09-05

Tested Date: 2016-09-05—2016-09-30

Issued by: Shenzhen Huatongwei International Inspection Co., Ltd.

Lab Location: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China.

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Test Report

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Manufacturer : ZTE CORPORATION

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Test Standards : 47 CFR Part 15 Subpart B: Radio Frequency Devices

Test Result : PASS

Tested by : Ling Min Xie

LingMin Xie Test Engineer 2016.09.30

Reviewed by : Zhu Qi

Zhu Qi Senior Engineer 2016.09.30

Approved by : Wu Li'an

Wu Li'an, Manager 2016.09.30

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Change History		
Issue	Date	Reason for change
1.0	2016.09.30	First edition

1. GENERAL INFORMATION

1.1 EUT Description

EUT Name : LTE Ufi

FCC ID..... : SRQ-R218

Trade Name.....: ZTE

Brand Name.....: ZTE

Hardware Version..... : Ver.B(T2)

Software Version : BD_R218V2.1

*Note 1:*The EUT is a LTE Ufi, it supports the following operating frequency band:GPRS850/900/1800/1900;WCDMA850/900/1900/2100;

LTE BAND 3,8,20;WIFI 2.4G(b/g/n20/40);

*Note 2:*The highest operation frequency or processor operate frequency is 1.3 GHz.

*Note 3:*For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B 2016	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B, Class B. The test procedure is according to ANSI C63.4:2009.

1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories

(identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories, Date of Registration: February 28, 2015. Valid time is until February 27, 2018.

FCC-Registration No.: 317478

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 317478, Renewal date Jul. 18, 2014, valid time is until Jul. 18, 2017.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	$U_c = 3.6 \text{ dB (k=2)}$
Uncertainty of Radiated Emission:	$U_c = 4.5 \text{ dB (k=2)}$

2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Support Equipment:

Description	Brand name	Model	Serial No.	FCCID
Notebook	ThinkPad	E430C	A131101550	N/A
Mouse	Logitech	M100r	25011051	DOC

Support Cable:

Description	Shield Type	Ferrite Core	Length
USB Cable	shielding	Yes	1.2m
RJ45 Cable	shielding	No	2m
PC Power adapter Cable	Un- shielding	No	1.2m
Mouse Cable	Un- shielding	No	1m

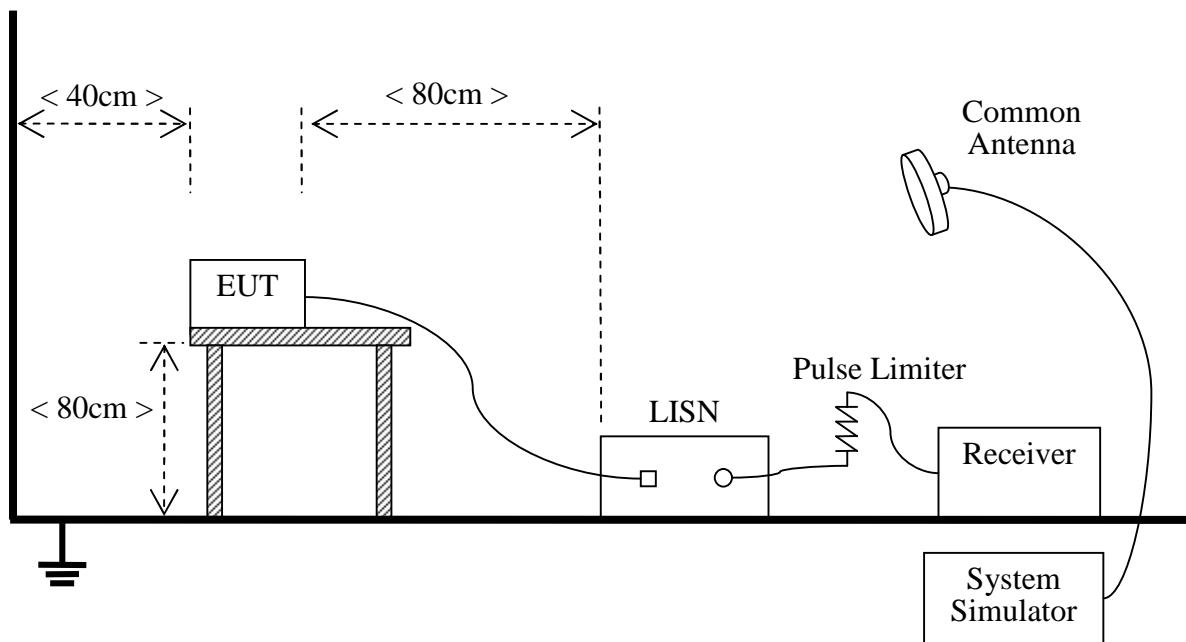
2.2 Test Mode

The EUT configuration of the emission tests is EUT + PC+Mouse.

2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

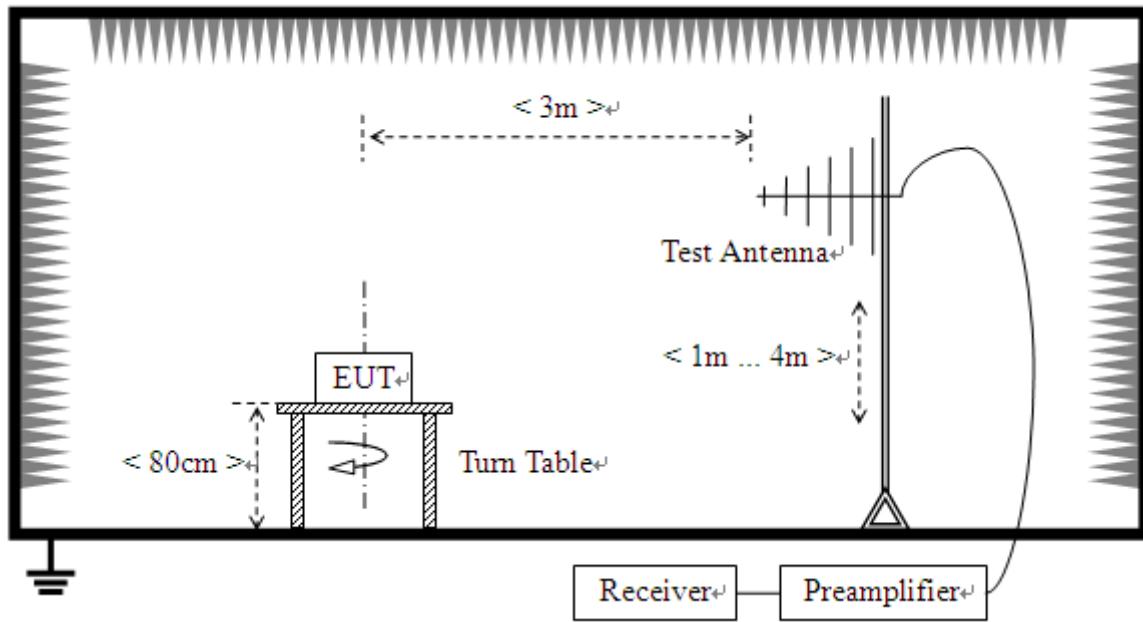
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESCI	A130901475	2015.09.08	2017.09.07
LISN	ROHDE&SCHWARZ	ENV216	/	2016.01.04	2017.01.03
Cable	MATCHING PAD	W7	/	2016.06.03	2017.06.02

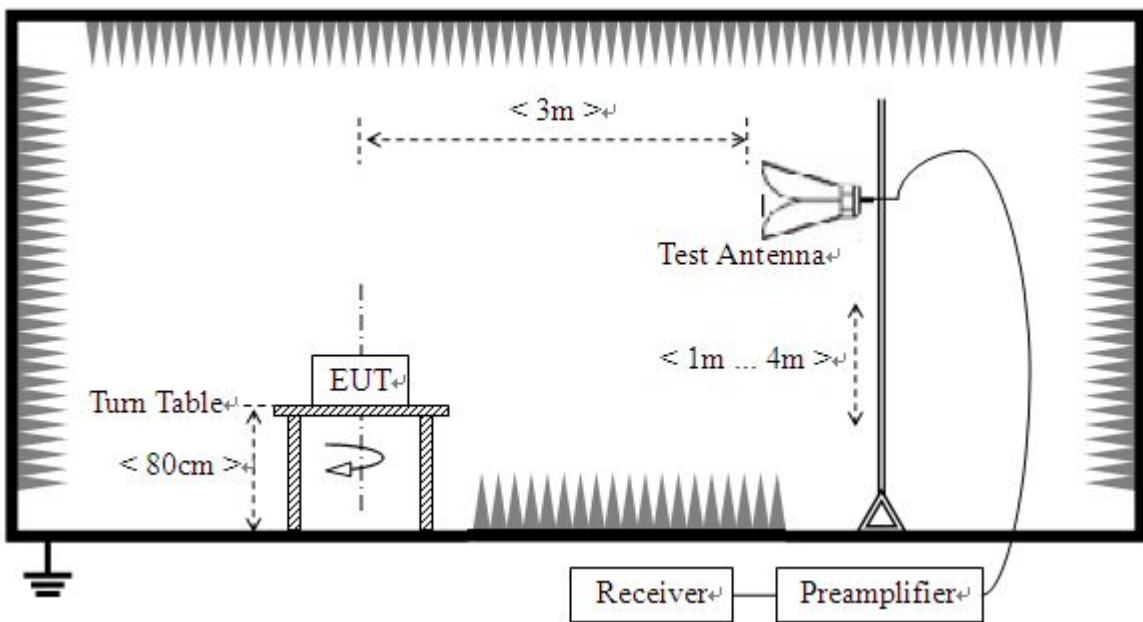
2.3.2 Radiated Emission

A. Test Setup:

- 1) For radiated emissions from 30MHz to 1GHz



2) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2016.06.04	2017.06.03
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2016.06.04	2017.06.03
Semi-Anechoic Chamber	Albatross	9m*6m*6m	A0412372	2016.05.09	2017.05.08
Test Antenna - Bi-Log	HP	CBL6111A	A9704202	2016.06.04	2017.06.03
Test Antenna – Horn	ROHDE&SCHWARZ	HF906	A0304225	2016.06.04	2017.06.03
Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4m	A0304210	2016.05.09	2017.05.08
Amplifier 1G~18GHz	ROHDE&SCHWARZ	MITEQ AFS42-001018 00	A0509366	2016.06.04	2017.06.03
Amplifier 20M~3GHz	Compliance Direction System	PAP-0203H	A0509377	2016.06.04	2017.06.03
Cable	SUNHNER	SUCOFLEX 100	/	2016.06.04	2017.06.03
Cable	SUNHNER	SUCOFLEX 104	MY1758/4	2016.06.04	2017.06.03

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

Note:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2 Test Description

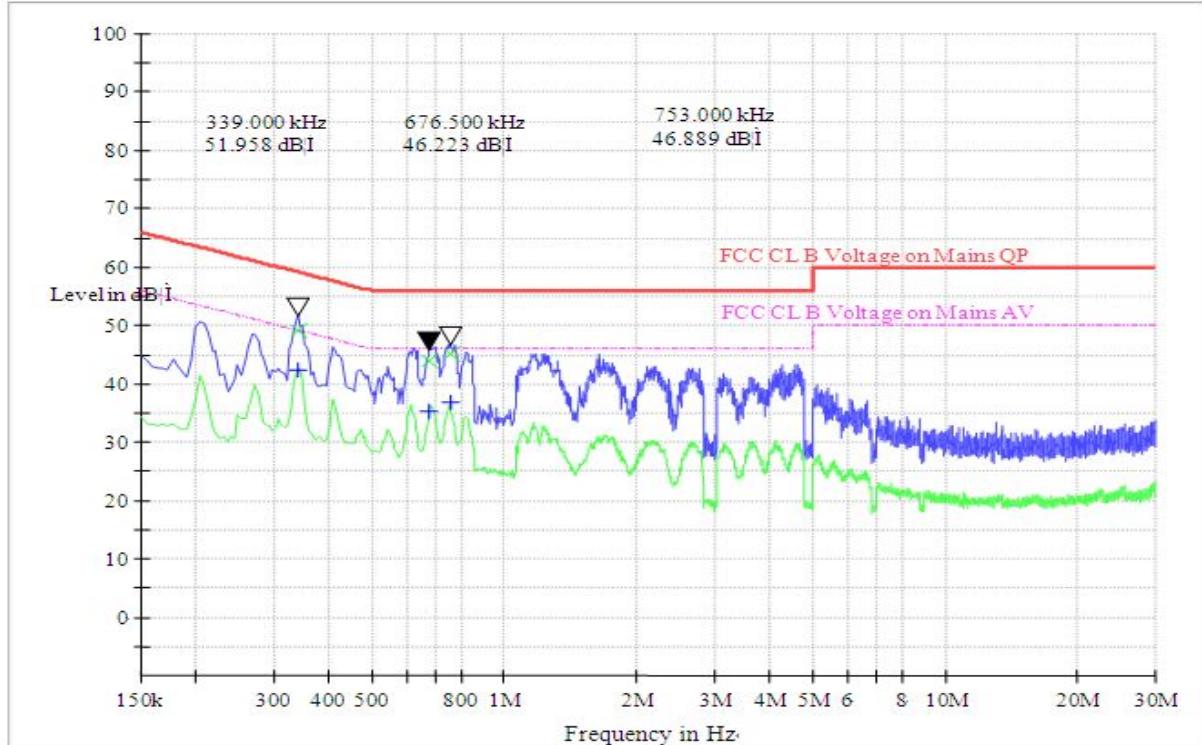
See section 2.3.1 of this report.

3.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

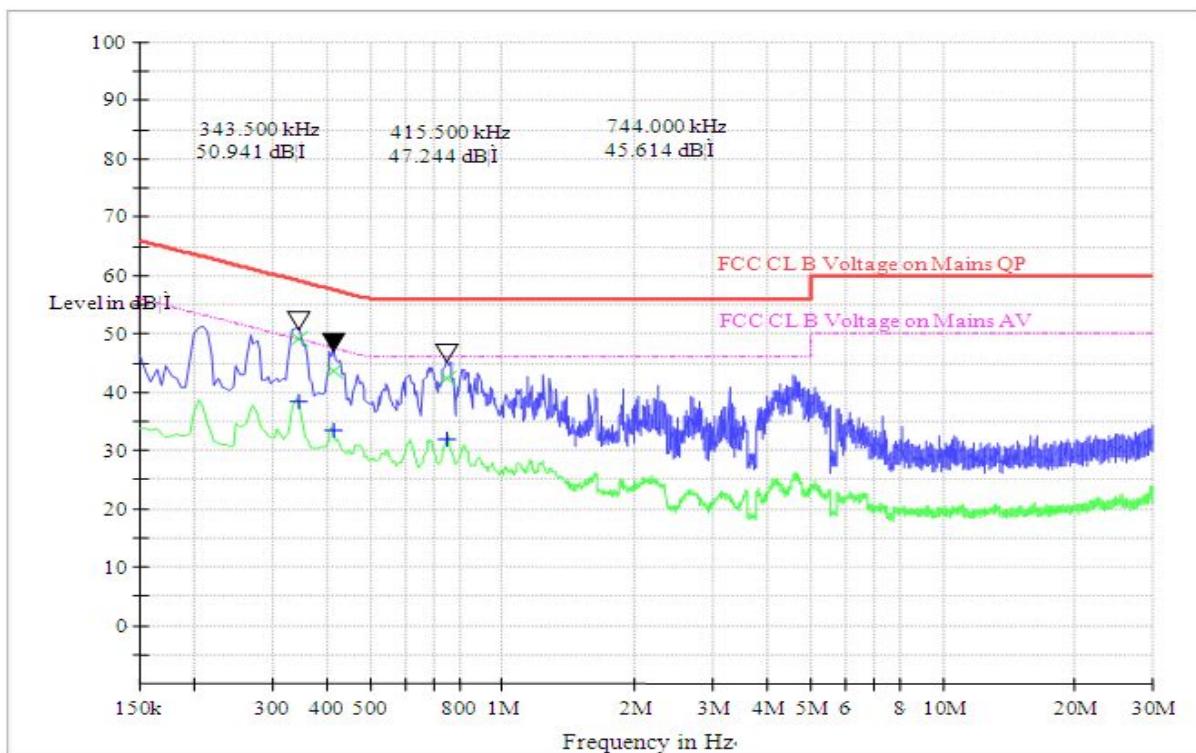
Note:

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a Nominal 120V AC,50/60Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Test voltage and frequency (120V AC,60Hz)
A. Test Plot and Suspicious Points:


(Plot A: L Phase)

Conducted Disturbance at Mains Terminals							
L Test Data							
QP				AV			
Frequency (MHz)	Limits (dB μ V)	Measurement Value (dB μ V)	Margin (dB)	Frequency (MHz)	Limits (dB μ V)	Measurement Value (dB μ V)	Margin (dB)
0.3390	59.20	49.06	10.14	0.3390	49.20	42.37	6.83
0.6765	56.00	43.92	12.08	0.6765	46.00	35.34	10.66
0.7530	56.00	45.28	10.72	0.7530	46.00	36.82	9.18



(Plot B: N Phase)

Conducted Disturbance at Mains Terminals							
N Test Data							
QP				AV			
Frequen cy (MHz)	Limits (dBµV)	Measureme nt Value (dBµV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measureme nt Value (dBµV)	Margin (dB)
0.3435	59.10	49.30	9.8	0.3435	49.10	38.34	10.76
0.4155	57.50	43.64	13.86	0.4155	47.50	33.49	14.01
0.7440	56.00	42.42	13.58	0.7440	46.00	31.89	14.11

Test Result: PASS

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength		Field Strength Limitation at 3m Measurement Dist	
	μ V/m	Dist	(uV/m)	(dBuV/m)
0.009 - 0.490	2400/F(kHz)	300m	10000* 2400/F(kHz)	20log 2400/F(kHz) + 80
0.490 - 1.705	2400/F(kHz)	30m	100* 2400/F(kHz)	20log 2400/F(kHz) + 40
1.705 - 30.00	30	30m	100*30	20log 30 + 40
30.0 - 88.0	100	3m	100	20log 100
88.0 - 216.0	150	3m	150	20log 150
216.0 - 960.0	200	3m	200	20log 200
Above 960.0	500	3m	500	20log 500

- a) As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- b) Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- c) For below 1G :QP detector RBW 120kHz ,VBW 300kHz.
- d) For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;AV detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as
 $Ld1 = Ld2 * (10)^2 = 100 * 30uV/m$.

3.2.2 Test Description

See section 2.3.2 of this report.

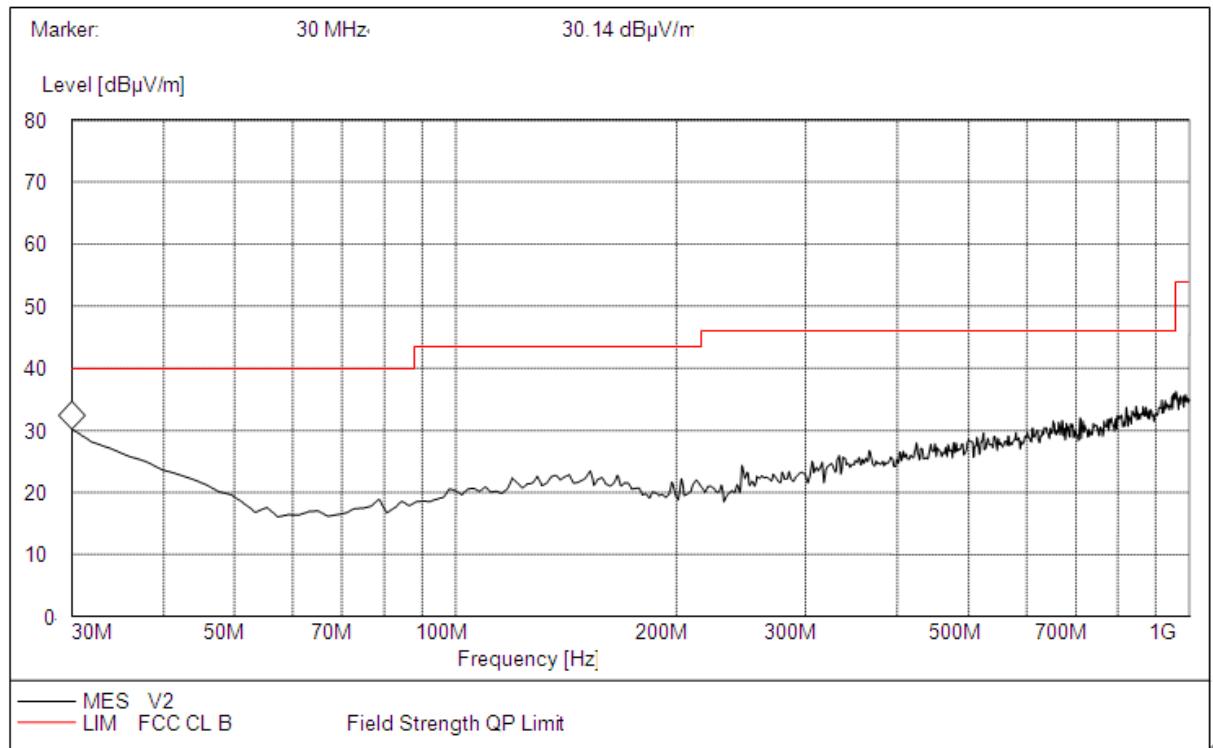
3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

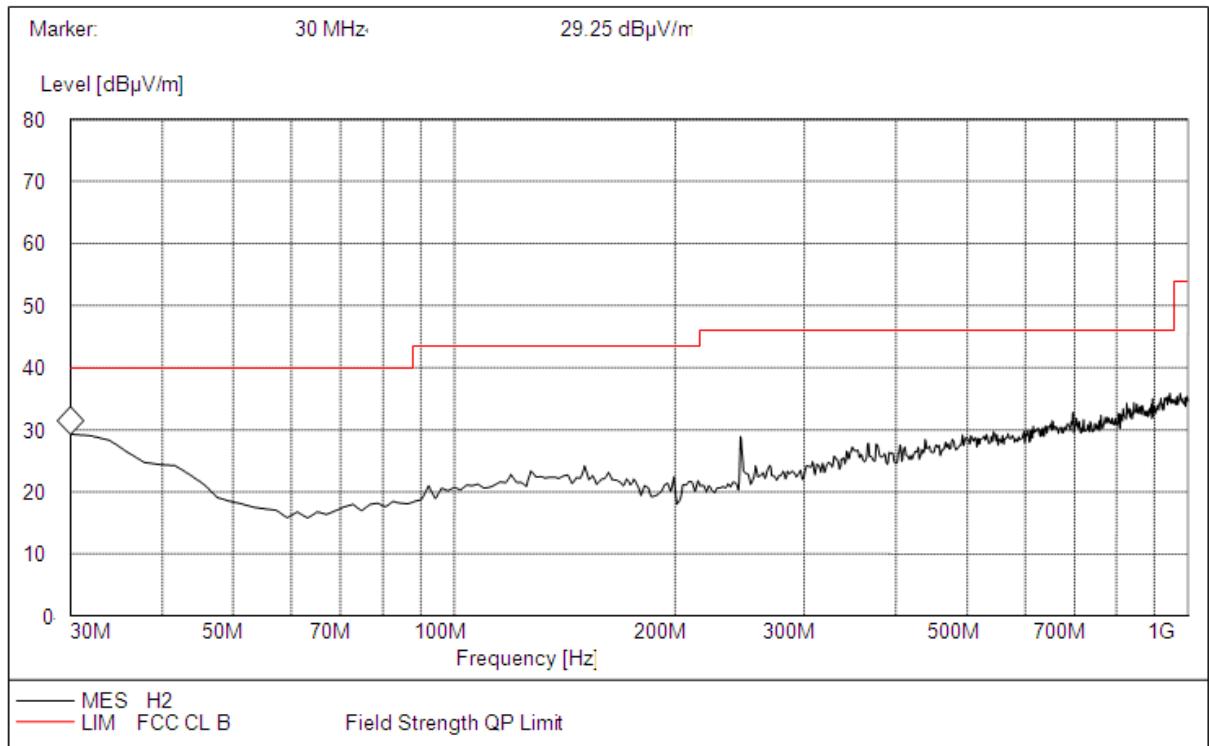
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

B. Test Plots and Suspicious Points:



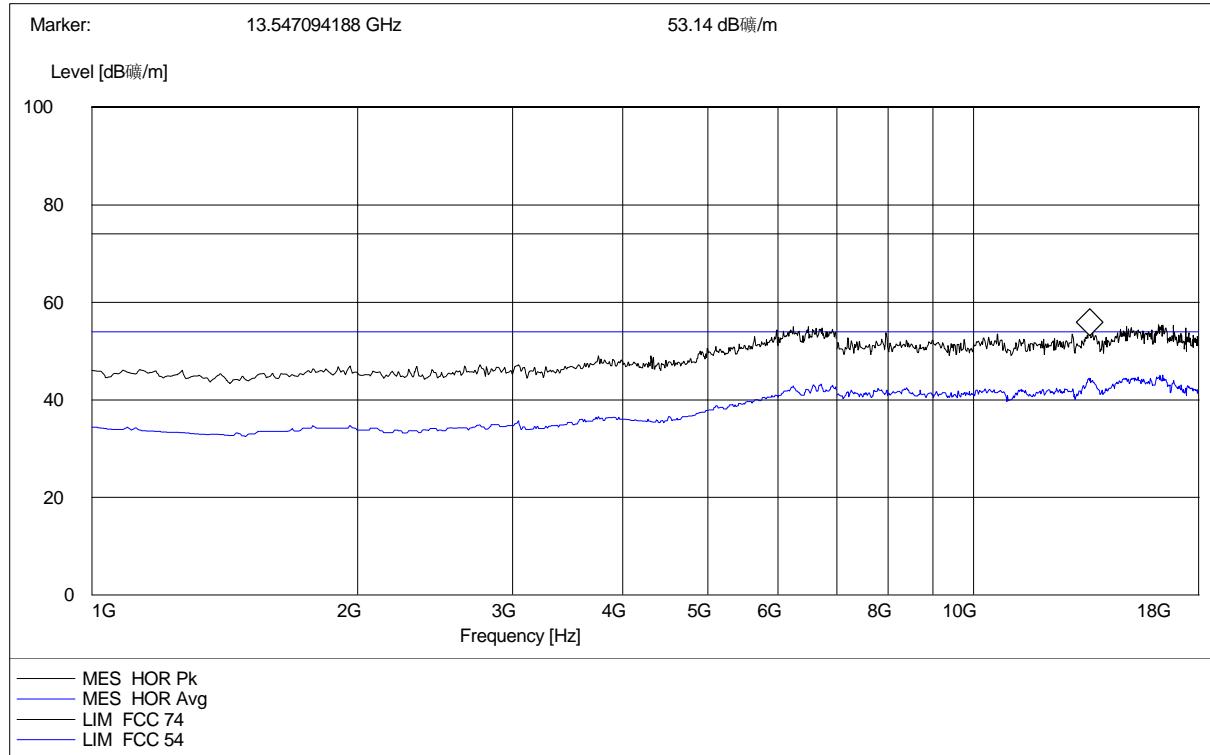
(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
30.00000	27.89	120.000	121.4	40.00	12.11	Vertical	Pass
152.34000	22.64	120.000	124.6	43.50	20.86	Vertical	Pass
177.84000	23.04	120.000	245.4	43.50	20.46	Vertical	Pass

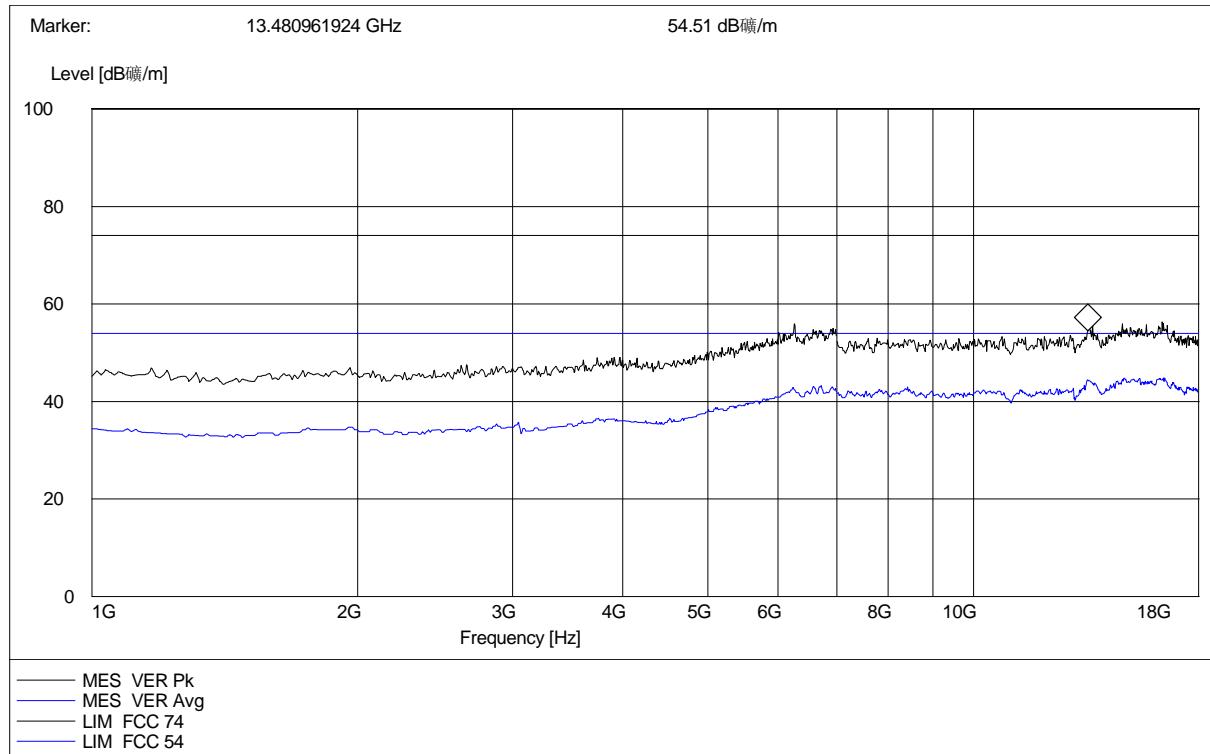


(Plot D: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
30.00000	28.31	120.000	114.5	40.00	11.69	Horizontal	Pass
169.54000	23.76	120.000	123.7	43.50	19.74	Horizontal	Pass
239.94000	27.63	120.000	169.0	46.00	18.37	Horizontal	Pass



(Plot E: Test Antenna Horizontal 1G – 18G)



(Plot F: Test Antenna Vertical 1G – 18G)

Test Result: PASS